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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Not For New Designs
Core Processor	STM8
Core Size	8-Bit
Speed	16MHz
Connectivity	I²C, IrDA, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, POR, PWM, WDT
Number of I/O	41
Program Memory Size	32KB (32K x 8)
Program Memory Type	FLASH
EEPROM Size	1K x 8
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	1.65V ~ 3.6V
Data Converters	A/D 25x12b; D/A 1x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm8al3l68tax

3.13 Timers

The medium-density STM8AL313x/4x/6x and STM8AL3L4x/6x devices contain one advanced control timer (TIM1), two 16-bit general purpose timers (TIM2 and TIM3) and one 8-bit basic timer (TIM4).

All the timers can be served by DMA1.

Table 3 compares the features of the advanced control, general-purpose and basic timers.

Table 3. Timer feature comparison

Timer	Counter resolution	Counter type	Prescaler factor	DMA1 request generation	Capture/compare channels	Complementary outputs
TIM1	16-bit	up/down	Any integer from 1 to 65536	Yes	3 + 1	3
TIM2			Any power of 2 from 1 to 128		2	None
TIM3						
TIM4	8-bit	up	Any power of 2 from 1 to 32768		0	

3.13.1 TIM1 - 16-bit advanced control timer

This is a high-end timer designed for a wide range of control applications. With its complementary outputs, dead-time control and center-aligned PWM capability, the field of applications is extended to motor control, lighting and half-bridge driver.

- 16-bit up, down and up/down auto reload counter with 16-bit prescaler
- Three independent capture/compare channels (CAPCOM) configurable as input capture, output compare, PWM generation (edge and center aligned mode) and single pulse mode output.
- One additional capture/compare channel which is not connected to an external I/O
- Synchronization module to control the timer with external signals
- Break input to force timer outputs into a defined state
- Three complementary outputs with adjustable dead time
- Encoder mode
- Interrupt capability on various events (capture, compare, overflow, break, trigger)

3.13.2 16-bit general purpose timers

- 16-bit auto reload (AR) up/down-counter
- 7-bit prescaler adjustable to fixed power of 2 ratios (1…128)
- Two individually configurable capture/compare channels
- PWM mode
- Interrupt capability on various events (capture, compare, overflow, break, trigger)
- Synchronization with other timers or external signals (external clock, reset, trigger and enable)

Single wire data interface (SWIM) and debug module

The debug module with its single wire data interface (SWIM) permits non-intrusive real-time in-circuit debugging and fast memory programming.

The Single wire interface is used for direct access to the debugging module and memory programming. The interface can be activated in all device operation modes.

The non-intrusive debugging module features a performance close to a full-featured emulator. Beside memory and peripherals, CPU operation can also be monitored in real-time by means of shadow registers.

Bootloader

A bootloader is available to reprogram the Flash memory using the USART1 interface. The reference document for the bootloader is *UM0560: STM8 bootloader user manual*.

Table 5. Medium-density STM8AL313x/4x/6x and STM8AL3L4x/6x pin description (continued)

Pin number			Pin name	Type	I/O level	Input			Output			Main function (after reset)	Default alternate function
LQFP48	VFQFPN32	LQFP32				floating	wpu	Ext. interrupt	High sink/source	OD	PP		
38	26	26	PC1(5)/I2C1_SCL	I/O	FT	X	-	X	-	T(7)		Port C1	I2C1 clock
41	27	27	PC2/USART1_RX/ LCD_SEG22/ADC1_IN6/ COMP1_INP/VREFINT	I/O	TT(3)	X	X	X	HS	X	X	Port C2	USART1 receive / LCD segment 22 / ADC1_IN6 / Comparator 1 positive input / Internal voltage reference output
42	28	28	PC3/USART1_TX/ LCD_SEG23(2)/ ADC1_IN5/COMP1_INP/ COMP2_INM	I/O	TT(3)	X	X	X	HS	X	X	Port C3	USART1 transmit / LCD segment 23 / ADC1_IN5 / Comparator 1 positive input / Comparator 2 negative input
43	29	29	PC4/USART1_CK/ I2C1_SMB/CCO/ LCD_SEG24(2)/ ADC1_IN4/COMP2_INM/ COMP1_INP	I/O	TT(3)	X	X	X	HS	X	X	Port C4	USART1 synchronous clock / I2C1_SMB / Configurable clock output / LCD segment 24 / ADC1_IN4 / Comparator 2 negative input / Comparator 1 positive input
44	30	30	PC5/OSC32_IN /*[SPI1_NSS]*(4)/ *[USART1_TX]*(4)	I/O	-	X	X	X	HS	X	X	Port C5	LSE oscillator input / *[SPI1 master/slave select] / [USART1 transmit]*
45	31	31	PC6/OSC32_OUT/ *[SPI1_SCK]*(4)/ *[USART1_RX]*(4)	I/O	-	X	X	X	HS	X	X	Port C6	LSE oscillator output / *[SPI1 clock] / [USART1 receive]*
46	-	-	PC7/LCD_SEG25(2)/ ADC1_IN3/COMP2_INM/ COMP1_INP	I/O	TT(3)	X	X	X	HS	X	X	Port C7	LCD segment 25 /ADC1_IN3/ Comparator negative input / Comparator 1 positive input

4.1 System configuration options

As shown in *Table 5: Medium-density STM8AL313x/4x/6x and STM8AL3L4x/6x pin description*, some alternate functions can be remapped on different I/O ports by programming one of the two remapping registers described in the “Routing interface (RI) and system configuration controller” section in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5055 to 0x00 506F	Reserved area (27 bytes)			
0x00 5070	DMA1	DMA1_GCSR	DMA1 global configuration & status register	0xFC
0x00 5071		DMA1_GIR1	DMA1 global interrupt register 1	0x00
0x00 5072 to 0x00 5074		Reserved area (3 bytes)		
0x00 5075		DMA1_C0CR	DMA1 channel 0 configuration register	0x00
0x00 5076		DMA1_C0SPR	DMA1 channel 0 status & priority register	0x00
0x00 5077		DMA1_C0NDTR	DMA1 number of data to transfer register (channel 0)	0x00
0x00 5078		DMA1_C0PARH	DMA1 peripheral address high register (channel 0)	0x52
0x00 5079		DMA1_C0PARL	DMA1 peripheral address low register (channel 0)	0x00
0x00 507A		Reserved area (1 byte)		
0x00 507B		DMA1_C0M0ARH	DMA1 memory 0 address high register (channel 0)	0x00
0x00 507C		DMA1_C0M0ARL	DMA1 memory 0 address low register (channel 0)	0x00
0x00 507D to 0x00 507E	Reserved area (2 bytes)			

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 508C	DMA1	DMA1_C2PARH	DMA1 peripheral address high register (channel 2)	0x52
0x00 508D		DMA1_C2PARL	DMA1 peripheral address low register (channel 2)	0x00
0x00 508E		Reserved area (1 byte)		
0x00 508F		DMA1_C2M0ARH	DMA1 memory 0 address high register (channel 2)	0x00
0x00 5090		DMA1_C2M0ARL	DMA1 memory 0 address low register (channel 2)	0x00
0x00 5091 0x00 5092		Reserved area (2 bytes)		
0x00 5093		DMA1_C3CR	DMA1 channel 3 configuration register	0x00
0x00 5094		DMA1_C3SPR	DMA1 channel 3 status & priority register	0x00
0x00 5095		DMA1_C3NDTR	DMA1 number of data to transfer register (channel 3)	0x00
0x00 5096		DMA1_C3PARH_ C3M1ARH	DMA1 peripheral address high register (channel 3)	0x40
0x00 5097		DMA1_C3PARL_ C3M1ARL	DMA1 peripheral address low register (channel 3)	0x00
0x00 5098		Reserved area (1 byte)		
0x00 5099		DMA1_C3M0ARH	DMA1 memory 0 address high register (channel 3)	0x00
0x00 509A		DMA1_C3M0ARL	DMA1 memory 0 address low register (channel 3)	0x00
0x00 509B to 0x00 509D		Reserved area (3 bytes)		
0x00 509E	SYSCFG	SYSCFG_RMPCR1	Remapping register 1	0x00
0x00 509F		SYSCFG_RMPCR2	Remapping register 2	0x00
0x00 50A0	ITC - EXTI	EXTI_CR1	External interrupt control register 1	0x00
0x00 50A1		EXTI_CR2	External interrupt control register 2	0x00
0x00 50A2		EXTI_CR3	External interrupt control register 3	0x00
0x00 50A3		EXTI_SR1	External interrupt status register 1	0x00
0x00 50A4		EXTI_SR2	External interrupt status register 2	0x00
0x00 50A5		EXTI_CONF1	External interrupt port select register 1	0x00
0x00 50A6	WFE	WFE_CR1	WFE control register 1	0x00
0x00 50A7		WFE_CR2	WFE control register 2	0x00
0x00 50A8		WFE_CR3	WFE control register 3	0x00

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 52E0	TIM4	TIM4_CR1	TIM4 control register 1	0x00
0x00 52E1		TIM4_CR2	TIM4 control register 2	0x00
0x00 52E2		TIM4_SMCR	TIM4 slave mode control register	0x00
0x00 52E3		TIM4_DER	TIM4 DMA1 request enable register	0x00
0x00 52E4		TIM4_IER	TIM4 interrupt enable register	0x00
0x00 52E5		TIM4_SR1	TIM4 status register 1	0x00
0x00 52E6		TIM4_EGR	TIM4 event generation register	0x00
0x00 52E7		TIM4_CNTR	TIM4 counter	0x00
0x00 52E8		TIM4_PSCR	TIM4 prescaler register	0x00
0x00 52E9		TIM4_ARR	TIM4 auto-reload register	0x00
0x00 52EA to 0x00 52FE	Reserved area (21 bytes)			
0x00 52FF	IRTIM	IR_CR	Infrared control register	0x00
0x00 5300 to 0x00 533F	Reserved area (64 bytes)			
0x00 5340	ADC1	ADC1_CR1	ADC1 configuration register 1	0x00
0x00 5341		ADC1_CR2	ADC1 configuration register 2	0x00
0x00 5342		ADC1_CR3	ADC1 configuration register 3	0x1F
0x00 5343		ADC1_SR	ADC1 status register	0x00
0x00 5344		ADC1_DRH	ADC1 data register high	0x00
0x00 5345		ADC1_DRL	ADC1 data register low	0x00
0x00 5346		ADC1_HTRH	ADC1 high threshold register high	0x0F
0x00 5347		ADC1_HTRL	ADC1 high threshold register low	0xFF
0x00 5348		ADC1_LTRH	ADC1 low threshold register high	0x00
0x00 5349		ADC1_LTRL	ADC1 low threshold register low	0x00
0x00 534A		ADC1_SQR1	ADC1 channel sequence 1 register	0x00
0x00 534B		ADC1_SQR2	ADC1 channel sequence 2 register	0x00
0x00 534C		ADC1_SQR3	ADC1 channel sequence 3 register	0x00
0x00 534D		ADC1_SQR4	ADC1 channel sequence 4 register	0x00
0x00 534E		ADC1_TRIGR1	ADC1 trigger disable 1	0x00
0x00 534F		ADC1_TRIGR2	ADC1 trigger disable 2	0x00
0x00 5350		ADC1_TRIGR3	ADC1 trigger disable 3	0x00
0x00 5351		ADC1_TRIGR4	ADC1 trigger disable 4	0x00

Table 9. General hardware register map (continued)

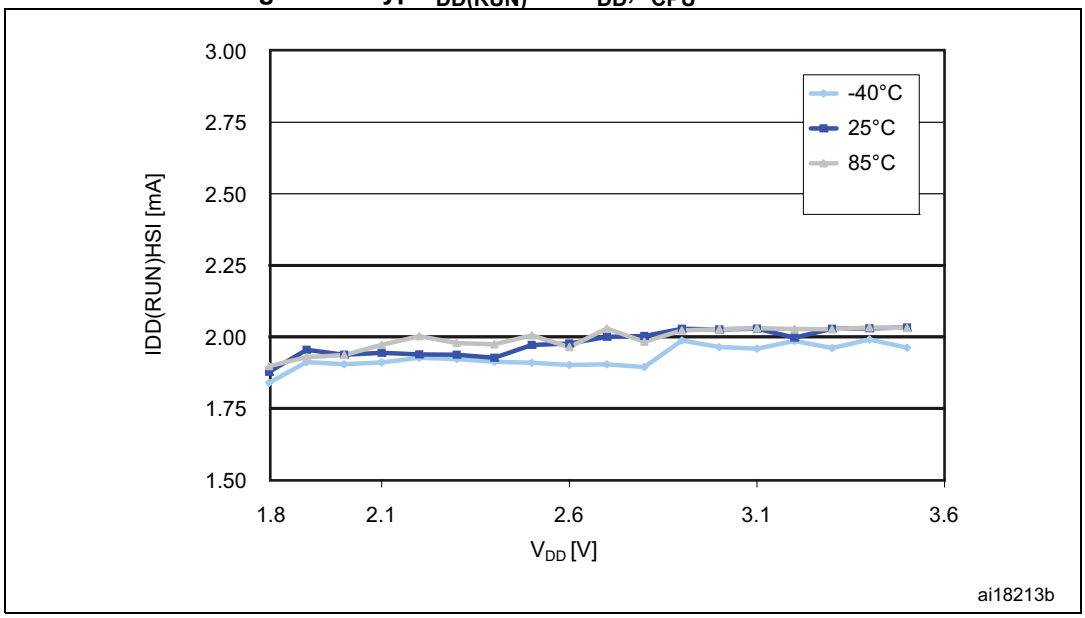
Address	Block	Register label	Register name	Reset status
0x00 5440	COMP	COMP_CSR1	Comparator control and status register 1	0x00
0x00 5441		COMP_CSR2	Comparator control and status register 2	0x00
0x00 5442		COMP_CSR3	Comparator control and status register 3	0x00
0x00 5443		COMP_CSR4	Comparator control and status register 4	0x00
0x00 5444		COMP_CSR5	Comparator control and status register 5	0x00

1. These registers are not impacted by a system reset. They are reset at power-on.

Table 10. CPU/SWIM/debug module/interrupt controller registers

Address	Block	Register Label	Register Name	Reset Status
0x00 7F00	CPU(1)	A	Accumulator	0x00
0x00 7F01		PCE	Program counter extended	0x00
0x00 7F02		PCH	Program counter high	0x00
0x00 7F03		PCL	Program counter low	0x00
0x00 7F04		XH	X index register high	0x00
0x00 7F05		XL	X index register low	0x00
0x00 7F06		YH	Y index register high	0x00
0x00 7F07		YL	Y index register low	0x00
0x00 7F08		SPH	Stack pointer high	0x03
0x00 7F09		SPL	Stack pointer low	0xFF
0x00 7F0A		CCR	Condition code register	0x28
0x00 7F0B to 0x00 7F5F	Reserved area (85 bytes)			
0x00 7F60	CPU	CFG_GCR	Global configuration register	0x00
0x00 7F70	ITC-SPR	ITC_SPR1	Interrupt Software priority register 1	0xFF
0x00 7F71		ITC_SPR2	Interrupt Software priority register 2	0xFF
0x00 7F72		ITC_SPR3	Interrupt Software priority register 3	0xFF
0x00 7F73		ITC_SPR4	Interrupt Software priority register 4	0xFF
0x00 7F74		ITC_SPR5	Interrupt Software priority register 5	0xFF
0x00 7F75		ITC_SPR6	Interrupt Software priority register 6	0xFF
0x00 7F76		ITC_SPR7	Interrupt Software priority register 7	0xFF
0x00 7F77		ITC_SPR8	Interrupt Software priority register 8	0xFF
0x00 7F78 to 0x00 7F79	Reserved area (2 bytes)			

Figure 13. Typ. $I_{DD(RUN)}$ vs. V_{DD}, f_{CPU} = 16 MHz(1)



1. Typical current consumption measured with code executed from RAM.

Table 22. Total current consumption in Wait mode

Symbol	Parameter	Conditions(1)			Typ	Max	Unit
$I_{DD(Wait)}$	Supply current in Wait mode	CPU not clocked, all peripherals OFF, code executed from RAM with Flash in I_{DDQ} mode,(2) V_{DD} from 1.65 V to 3.6 V	HSI	f_{CPU} = 125 kHz	0.35	0.45(3)	mA
				f_{CPU} = 1 MHz	0.35	0.50(3)	
				f_{CPU} = 4 MHz	0.40	0.60(3)	
				f_{CPU} = 8 MHz	0.50	0.60(3)	
				f_{CPU} = 16 MHz	0.70	0.85	
			HSE external clock (f_{CPU}=f_{HSE})(4)	f_{CPU} = 125 kHz	0.05	0.10(3)	
				f_{CPU} = 1 MHz	0.10	0.20(3)	
				f_{CPU} = 4 MHz	0.20	0.40(3)	
				f_{CPU} = 8 MHz	0.40	0.65(3)	
				f_{CPU} = 16 MHz	0.76	1.15(3)	
			LSI	f_{CPU} = f_{LSI}	0.06	0.08(3)	
			LSE(5) external clock (32.768 kHz)	f_{CPU} = f_{LSE}	0.05	0.07(3)	

Current consumption of on-chip peripherals

Table 28. Peripheral current consumption

Symbol	Parameter		Typ. V_{DD} = 3.0 V	Unit
$I_{DD(TIM1)}$	TIM1 supply current(1)		13	µA/MHz
$I_{DD(TIM2)}$	TIM2 supply current (1)		8	
$I_{DD(TIM3)}$	TIM3 supply current (1)		8	
$I_{DD(TIM4)}$	TIM4 timer supply current (1)		3	
$I_{DD(USART1)}$	USART1 supply current (2)		6	
$I_{DD(SPI1)}$	SPI1 supply current (2)		3	
$I_{DD(I2C1)}$	I^2C1 supply current (2)		5	
$I_{DD(DMA1)}$	DMA1 supply current(2)		3	
$I_{DD(WWDG)}$	WWDG supply current(2)		2	
$I_{DD(ALL)}$	Peripherals ON(3)		44	
$I_{DD(ADC1)}$	ADC1 supply current(4)		1500	µA
$I_{DD(DAC)}$	DAC supply current(5)		370	
$I_{DD(COMP1)}$	Comparator 1 supply current(6)		0.160	
$I_{DD(COMP2)}$	Comparator 2 supply current(6)	Slow mode	2	
		Fast mode	5	
$I_{DD(PVD/BOR)}$	Power voltage detector and brownout Reset unit supply current (7)		2.6	
$I_{DD(BOR)}$	Brownout Reset unit supply current (7)		2.4	
$I_{DD(IDWDG)}$	Independent watchdog supply current	including LSI supply current	0.45	
		excluding LSI supply current	0.05	

1. Data based on a differential I_{DD} measurement between all peripherals OFF and a timer counter running at 16 MHz. The CPU is in Wait mode in both cases. No IC/OC programmed, no I/O pins toggling. Not tested in production.
2. Data based on a differential I_{DD} measurement between the on-chip peripheral in reset configuration and not clocked and the on-chip peripheral when clocked and not kept under reset. The CPU is in Wait mode in both cases. No I/O pins toggling. Not tested in production.
3. Peripherals listed above the $I_{DD(ALL)}$ parameter ON: TIM1, TIM2, TIM3, TIM4, USART1, SPI1, I2C1, DMA1, WWDG.
4. Data based on a differential I_{DD} measurement between ADC in reset configuration and continuous ADC conversion.
5. Data based on a differential I_{DD} measurement between DAC in reset configuration and continuous DAC conversion of V_{DD} /2. Floating DAC output.
6. Data based on a differential I_{DD} measurement between COMP1 or COMP2 in reset configuration and COMP1 or COMP2 enabled with static inputs. Supply current of internal reference voltage excluded.
7. Including supply current of internal reference voltage.

Table 40. I/O current injection susceptibility

Symbol	Description	Functional susceptibility		Unit
		Negative injection	Positive injection	
I_{INJ}	Injected current on true open-drain pins (PC0 and PC1)	-5	+0	mA
	Injected current on all five-volt tolerant (FT) pins	-5	+0	
	Injected current on all 3.6 V tolerant (TT) pins	-5	+0	
	Injected current on any other pin	-5	+5	

9.3.7 I/O port pin characteristics

General characteristics

Subject to general operating conditions for V_{DD} and T_A unless otherwise specified. All unused pins must be kept at a fixed voltage: using the output mode of the I/O for example or an external pull-up or pull-down resistor.

Table 41. I/O static characteristics

Symbol	Parameter	Conditions[1]	Min	Typ	Max	Unit
V_{IL}	Input low level voltage	Input voltage on all pins	V_{SS}-0.3	-	0.3 x V_{DD}	V
V_{IH}	Input high level voltage	Input voltage on true open-drain pins (PC0 and PC1) with V_{DD} < 2 V	0.70 x V_{DD}	-	5.2(2)	
		Input voltage on true open-drain pins (PC0 and PC1) with V_{DD} ≥ 2 V		-	5.5(2)	
		Input voltage on five-volt tolerant (FT) pins (PA7 and PE0) with V_{DD} < 2 V	0.70 x V_{DD}	-	5.2(2)	
		Input voltage on five-volt tolerant (FT) pins (PA7 and PE0) with V_{DD} ≥ 2 V		-	5.5(2)	
		Input voltage on 3.6 V tolerant (TT) pins		-	3.6(2)	
		Input voltage on any other pin	0.70 x V_{DD}	-	V_{DD}+0.3(2)	
V_{hys}	Schmitt trigger voltage hysteresis (3)	I/Os	-	200	-	mV
		True open drain I/Os	-	200	-	
I_{lkg}	Input leakage current (4)	$V_{SS} \le V_{IN} \le V_{DD}$ High sink I/Os	-	-	50	nA
		$V_{SS} \le V_{IN} \le V_{DD}$ True open drain I/Os	-	-	200	
		$V_{SS} \le V_{IN} \le V_{DD}$ PA0 with high sink LED driver capability	-	-	200	

Table 41. I/O static characteristics (continued)

Symbol	Parameter	Conditions(1)	Min	Typ	Max	Unit
R_{PU}	Weak pull-up equivalent resistor(5)	$V_{IN} = V_{SS}$	30(6)	45	60(6)	kΩ
C_{IO}	I/O pin capacitance	-	-	5	-	pF

1. V_{DD} = 3.0 V, T_A = -40 to 125 °C unless otherwise specified.
2. If V_{IH} maximum cannot be respected, the injection current must be limited externally to $I_{INJ(PIN)}$ maximum.
3. Hysteresis voltage between Schmitt trigger switching levels. Based on characterization results, not tested.
4. The max. value may be exceeded if negative current is injected on adjacent pins.
5. R_{PU} pull-up equivalent resistor based on a resistive transistor (corresponding I_{PU} current characteristics described in *Figure 22*).
6. Data not tested in production.

Figure 19. Typical V_{IL} and V_{IH} vs V_{DD} (high sink I/Os)

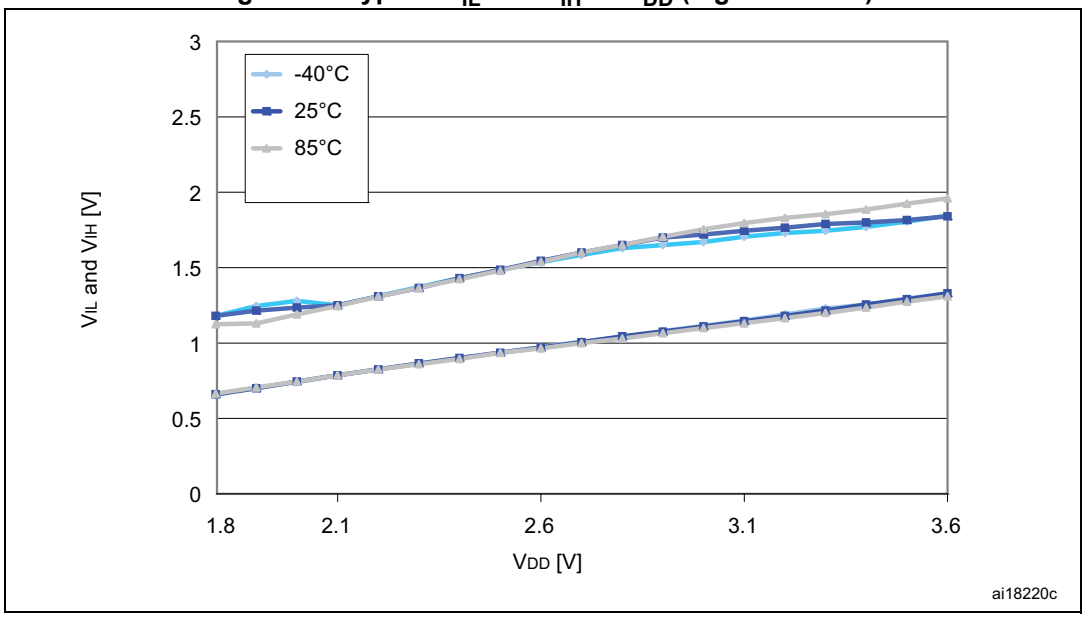


Figure 22. Typical pull-up current I_{pu} vs V_{DD} with $V_{IN}=V_{SS}$

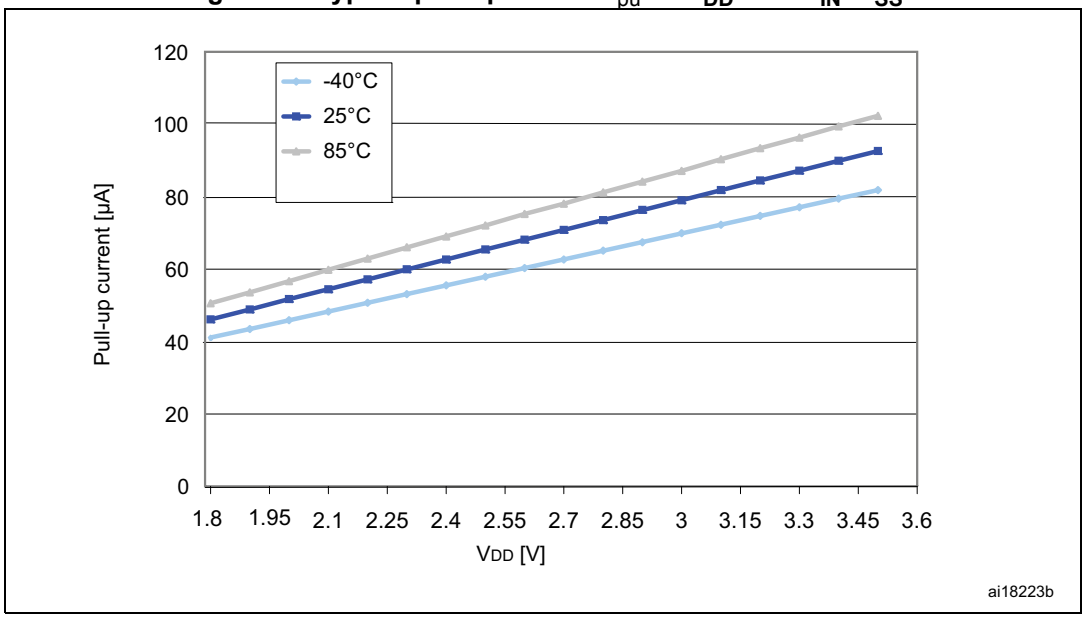


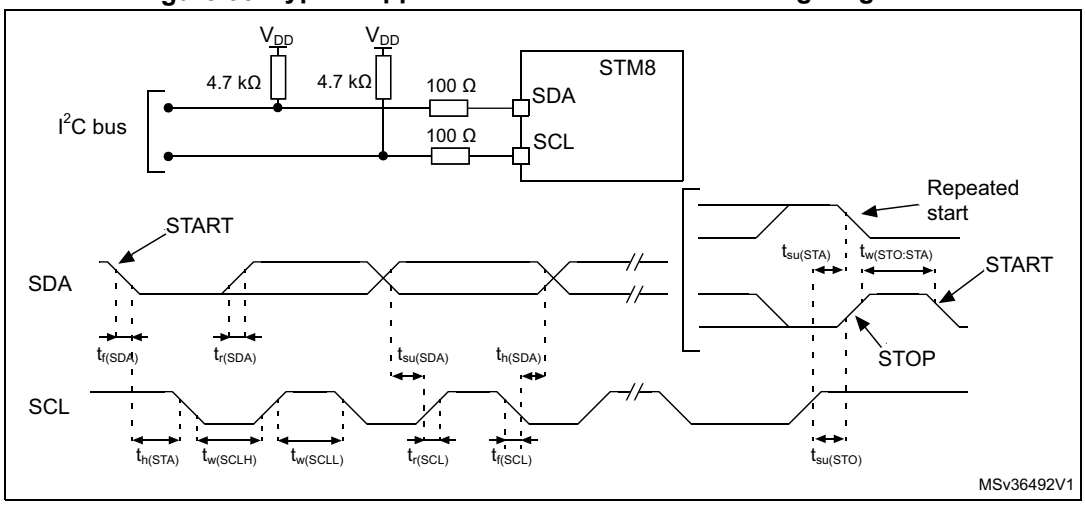
Table 47. I²C characteristics (continued)

Symbol	Parameter	Standard mode I²C		Fast mode I²C(1)		Unit
		Min(2)	Max (2)	Min (2)	Max (2)	
$t_{su(SDA)}$	SDA setup time	250	-	100	-	ns
$t_{h(SDA)}$	SDA data hold time	0	-	0	900	
$t_{r(SDA)}$ $t_{r(SCL)}$	SDA and SCL rise time	-	1000	-	300	
$t_{f(SDA)}$ $t_{f(SCL)}$	SDA and SCL fall time	-	300	-	300	
$t_{h(STA)}$	START condition hold time	4.0		0.6	-	µs
$t_{su(STA)}$	Repeated START condition setup time	4.7	-	0.6	-	
$t_{su(STO)}$	STOP condition setup time	4.0	-	0.6	-	
$t_{w(STO:STA)}$	STOP to START condition time (bus free)	4.7	-	1.3	-	
C_b	Capacitive load for each bus line	-	400	-	400	pF

1. f_{SYSCLK} must be at least equal to 8 MHz to achieve max fast I²C speed (400 kHz).
2. Data based on standard I²C protocol requirements, not tested in production.

Note: For speeds around 200 kHz, the achieved speed can have a ± 5% tolerance
For other speed ranges, the achieved speed can have a ± 2% tolerance
The above variations depend on the accuracy of the external components used.

Figure 35. Typical application with I²C bus and timing diagram(1)



1. Measurement points are done at CMOS levels: 0.3 x V_{DD} and 0.7 x V_{DD}

Table 49. Reference voltage characteristics

Symbol	Parameter	Conditions	Min	Typ	Max.	Unit
I_{REFINT}	Internal reference voltage consumption	-	-	1.4	-	µA
$T_{S\_VREFINT}$(1)(2)	ADC sampling time when reading the internal reference voltage	-	-	5	10	µs
I_{BUF}(2)	Internal reference voltage buffer consumption (used for ADC)	-	-	13.5	25	µA
$V_{REFINT\ out}$	Reference voltage output	-	1.202 (3)	1.224	1.242 (3)	V
I_{LPBUF}(2)	Internal reference voltage low power buffer consumption (used for comparators or output)	-	-	730	1200	nA
I_{REFOUT}(2)	Buffer output current(4)	-	-	-	1	µA
C_{REFOUT}	Reference voltage output load	-	-	-	50	pF
$t_{VREFINT}$	Internal reference voltage startup time	-	-	2	3	ms
t_{BUFEN}(2)	Internal reference voltage buffer startup time once enabled (1)	-	-	-	10	µs
$ACC_{VREFINT}$	Accuracy of V_{REFINT} stored in the VREFINT_Factory_CONV byte(5)	-	-	-	± 5	mV
$STAB_{VREFINT}$(2)	Stability of V_{REFINT} over temperature	-40 °C ≤ T_A ≤ 125 °C	-	20	50	ppm/°C
	Stability of V_{REFINT} over temperature	0 °C ≤ T_A ≤ 50 °C	-	-	20	
$STAB_{VREFINT}$(2)	Stability of V_{REFINT} after 1000 hours	-	-	-	1000	ppm

1. Defined when ADC output reaches its final value ±1/2LSB
2. Guaranteed by design.
3. Tested in production at V_{DD} = 3 V ±10 mV.
4. To guaranty less than 1% V_{REFOUT} deviation.
5. Measured at V_{DD} = 3 V ±10 mV. This value takes into account V_{DD} accuracy and ADC conversion accuracy.

9.3.11 Temperature sensor

In the following table, data are based on characterization results, not tested in production, unless otherwise specified.

Table 50. TS characteristics

Symbol	Parameter	Min	Typ	Max.	Unit
V_{125}(1)	Sensor reference voltage at 125 °C ±5 °C	0.640	0.660	0.680	V
T_L	V_{SENSOR} linearity with temperature	-	±1	±2	°C
Avg_slope	Average slope	1.59(2)	1.62	1.65(2)	mV/°C
$I_{DD(TEMP)}$	Consumption	-	3.4	6(2)	µA

Table 56. ADC1 characteristics (continued)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_S	Sampling time	V_{AIN} on PF0 fast channel V_{DDA} < 2.4 V	0.43(4)(5)	-	-	µs
		V_{AIN} on PF0 fast channel 2.4 V ≤ V_{DDA} ≤ 3.6 V	0.22(4)(5)	-	-	
		V_{AIN} on slow channels V_{DDA} < 2.4 V	0.86(4)(5)	-	-	
		V_{AIN} on slow channels 2.4 V ≤ V_{DDA} ≤ 3.6 V	0.41(4)(5)	-	-	
t_{conv}	12-bit conversion time	-	12000000 / f_{ADC} + t_S			
		16 MHz	1(4)	-	-	
t_{WKUP}	Wakeup time from OFF state	-	-	-	3	
t_{IDLE}(6)	Time before a new conversion	-	-	-	∞	s
$t_{VREFINT}$	Internal reference voltage startup time	-	-	-	refer to *Table 49*	ms

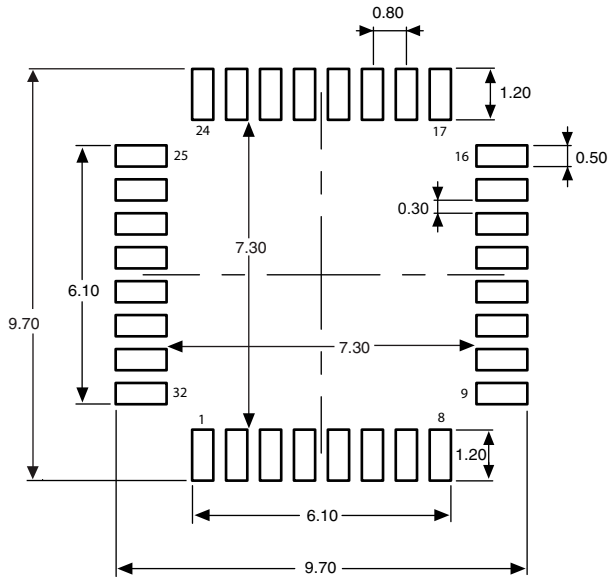
1. The current consumption through V_{REF} is composed of two parameters:
   - one constant (max 300 µA)
   - one variable (max 400 µA), only during sampling time + 2 first conversion pulses.
   So, peak consumption is 300+400 = 700 µA and average consumption is 300 + [(4 sampling + 2) /16] x 400 = 450 µA at 1Msps
2. V_{REF-} or V_{DDA} must be tied to ground.
3. Guaranteed by design.
4. Minimum sampling and conversion time is reached for maximum Rext = 0.5 kΩ.
5. Value obtained for continuous conversion on fast channel.
6. In STM8L05xx, STM8L15xx, STM8L162x, STM8AL31xx, STM8AL3Lxx, STM8AL31Exx and STM8AL3LExx MCU families reference manual (RM0031), t_{IDLE} defines the time between 2 conversions, or between ADC ON and the first conversion. t_{IDLE} is not relevant for this device.

Table 66. LQFP32 - 32-pin, 7 x 7 mm low-profile quad flat package mechanical data

Symbol	millimeters			inches[1]		
	Min	Typ	Max	Min	Typ	Max
A	-	-	1.600	-	-	0.0630
A1	0.050	-	0.150	0.0020	-	0.0059
A2	1.350	1.400	1.450	0.0531	0.0551	0.0571
b	0.300	0.370	0.450	0.0118	0.0146	0.0177
c	0.090	-	0.200	0.0035	-	0.0079
D	8.800	9.000	9.200	0.3465	0.3543	0.3622
D1	6.800	7.000	7.200	0.2677	0.2756	0.2835
D3	-	5.600	-	-	0.2205	-
E	8.800	9.000	9.200	0.3465	0.3543	0.3622
E1	6.800	7.000	7.200	0.2677	0.2756	0.2835
E3	-	5.600	-	-	0.2205	-
e	-	0.800	-	-	0.0315	-
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1	-	1.000	-	-	0.0394	-
k	0°	3.5°	7°	0°	3.5°	7°
ccc	-	-	0.100	-	-	0.0039

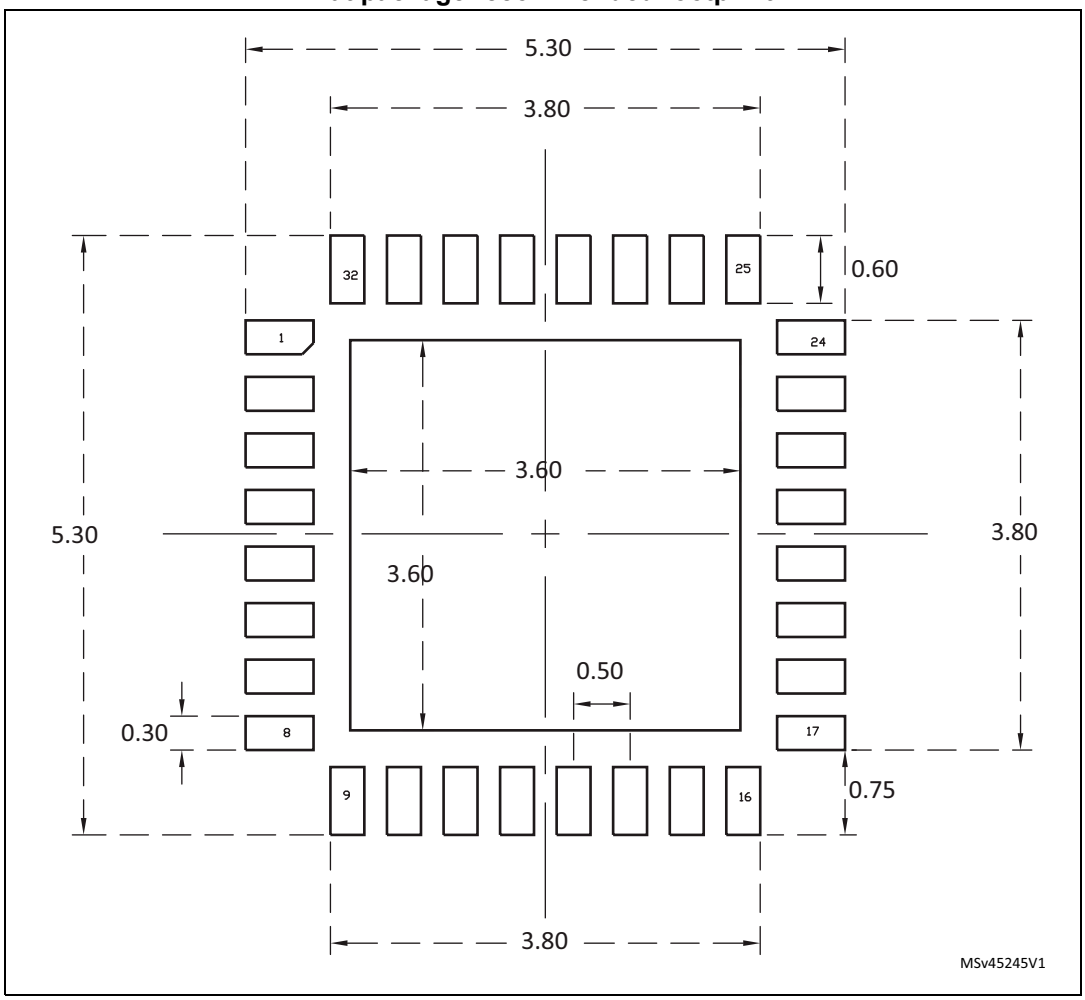
1. Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 45. LQFP32 - 32-pin, 7 x 7 mm low-profile quad flat recommended footprint



1. Dimensions are expressed in millimeters.

Figure 48. VFQFPN32 - 32-pin, 5x5 mm, 0.5 mm pitch very thin profile fine pitch quad flat package recommended footprint



1. Dimensions are expressed in millimeters.

Table 69. Document revision history (continued)

Date	Revision	Changes
03-Mar-2014	5	Changed the document status to Datasheet - Production data to reflect the device maturity. Corrected the data memory size in the *Features*. Updated the package assignment in *Table 2: Medium-density STM8AL313x/4x/6x and STM8AL3L4x/6x low-power device features and peripheral counts*
13-May-2015	6	Updated: – the product names in the document headers and on the cover page, – *Section 1: Introduction*, – the captions of *Figure 3: STM8AL31x8T 48-pin pinout (without LCD)*, *Figure 4: STM8AL3Lx8T 48-pin pinout (with LCD)*, *Figure 5: STM8AL31x6T 32-pin pinout (without LCD)*, *Figure 6: STM8AL3Lx6T 32-pin pinout (with LCD)*, – *Table 6: Flash and RAM boundary addresses*, – I_{LEAK_HSE} maximum value in *Table 32: HSE oscillator characteristics*,I_{LEAK_LSE} maximum value in *Table 33: LSE oscillator characteristics*, – *Table 54*, *Table 57*, *Table 58*, *Table 59* with a footnote for Max values not tested in production, – *Section 9.3.15: EMC characteristics*, – *Section 10.2: LQFP48 package information*, – *Section 10.3: LQFP32 package information*, – *Figure 50: Medium-density STM8AL313x/4x/6x and STM8AL3L4x/6x ordering information scheme*. Added: – *Figure 43: LQFP48 marking example (package top view)*, – *Figure 46: LQFP32 marking example (package top view)*. Moved *Section 10.5: Thermal characteristics* to *Section 10: Package information*.

Table 69. Document revision history (continued)

Date	Revision	Changes
18-Oct-2016	7	Added: – *Section 10.4: VFQFPN32 package information* – *Figure 7: STM8AL31x6U 32-pin pinout (without LCD)* – *Figure 8: STM8AL3Lx6U 32-pin pinout (with LCD)* Updated: – *Section 9.2: Absolute maximum ratings* – *Section : Device marking on page 110*, *Section : Device marking on page 113* and *Section : Device marking on page 117* – *Table 2: Medium-density STM8AL313x/4x/6x and STM8AL3L4x/6x low-power device features and peripheral counts* – *Table 5: Medium-density STM8AL313x/4x/6x and STM8AL3L4x/6x pin description* – *Table 19: General operating conditions* – *Table 68: Thermal characteristics* – *Figure 33: SPI1 timing diagram - slave mode and CPHA=1(1)* – *Figure 34: SPI1 timing diagram - master mode(1)* – *Figure 50: Medium-density STM8AL313x/4x/6x and STM8AL3L4x/6x ordering information scheme* – Footnotes on *Figure 43: LQFP48 marking example (package top view)* and *Figure 46: LQFP32 marking example (package top view)*
28-Mar-2017	8	Updated: – *Table 67: VFQFPN32 - 32-pin, 5x5 mm, 0.5 mm pitch very thin profile fine pitch quad flat package mechanical data* – *Figure 48: VFQFPN32 - 32-pin, 5x5 mm, 0.5 mm pitch very thin profile fine pitch quad flat package recommended footprint*